


<b>Search Notes</b>  	<b>Application/Control No.</b>  10598446	<b>Applicant(s)/Patent Under Reexamination</b>  ONISHI ET AL.
	<b>Examiner</b>  JESSE A ELBIN	<b>Art Unit</b>  2615

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
Discussion with Suhan Ni	09/11/2008	JAE
Email correspondence with Brian Ensey	09/15/2008	JAE

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

--	--